

**Notice of References Cited**

Application/Control No.

10/086,590

Applicant(s)/Patent Under

Reexamination

RUFF ET AL.

Examiner

Daniel Matz

Art Unit

3641

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,493,146	01-1985	Cronin, Michael J.	29/857
	B	US-5,534,665	07-1996	Long, Charles F.	174/72A
	C	US-4,871,134	10-1989	Oikawa, Ryuetsu	248/65
	D	US-4,815,984	03-1989	Sugiyama et al.	439/211
	E	US-6,159,030	12-2000	Gawron et al.	439/247
	F	US-5,010,642	04-1991	Takahashi et al.	29/868
	G	US-5,501,605	03-1996	Ozaki et al.	439/34
	H	US-5,739,470	04-1998	Takeda, Ikuo	174/97
	I	US-3,859,724	01-1975	Folkenroth, Earl Ernest	29/867
	J	US-5,800,208	09-1998	Ishizuka et al.	439/557
	K	US-5,106,033	04-1992	Phan, Dzung V.	244/3.12
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-2001-190010-A	10-2001	Japan	Katsuji et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.